MOSFET, N-Channel Shielded Gate, POWERTRENCH®

80 V, 136 A, 3.5 mΩ

General Description

This N-Channel MV MOSFET is produced using ON Semiconductor's advanced POWERTRENCH® process that incorporates Shielded Gate technology. This process has been optimized to minimise on-state resistance and yet maintain superior switching performance with best in class soft body diode.

Features

- Shielded Gate MOSFET Technology
- Max $r_{DS(on)} = 3.5 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 45 \text{ A}$
- Max $r_{DS(on)} = 5.1 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 36 \text{ A}$
- 50% Lower Qrr than Other MOSFET Suppliers
- Lowers Switching Noise/EMI
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant

Typical Applications

- Primary DC-DC MOSFET
- Synchronous Rectifier in DC-DC and AC-DC
- Motor Drive
- Solar

MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
V _{DS}	Drain to Source Voltage	80	٧
V _{GS}	Gate to Source Voltage	±20	٧
I _D	Drain Current – Continuous $T_C = 25^{\circ}C$ (Note 5)	136	Α
	Continuous T_C = 100°C (Note 5)	86	
	− Continuous T _A = 25°C (Note 1a)	19	
	- Pulsed (Note 4)	745	
E _{AS}	Single Pulse Avalanche Energy	486	mJ
P _D	Power dissipation T _C = 25°C	125	W
	Power dissipation T _A = 25°C (Note 1a)	2.5	
T _{J,} T _{STG}	Operating and Storage Junction Temperature Range	–55 to +150	°C

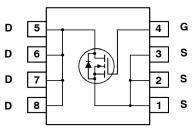
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



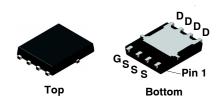
ON Semiconductor®

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ELECTRICAL CONNECTION



N-Channel MOSFET



Power 56 (PQFN8 5x6) CASE 483AE

MARKING DIAGRAM

\$Y&Z&3&K FDMS 3D5N08LC

\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Numeric Date Code &K = Lot Code

FDMS3D5N08LC = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.0	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Shipping [†]
FDMS3D5N08LC	FDMS3D5N08LC	PQFN8 5×6 (Pb–Free/Halogen Free)	3000 Units/ Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARA	ACTERISTICS	•				
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{V}$	80			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C		69		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 64 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate-to-Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V			±100	nA
ON CHARA	CTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.4	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C		-5.2		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 45 A		2.8	3.5	mΩ
		V _{GS} = 4.5 V, I _D = 36 A		4.0	5.1	1
		V _{GS} = 10 V, I _D = 45 A, T _J = 125°C		4.8	6.0	
9FS	Forward Transconductance	V _{DS} = 5 V, I _D = 45 A		300		S
DYNAMIC C	CHARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 40 V, V _{GS} = 0 V, f = 1MHz		4375	6125	
C _{oss}	Output Capacitance			1025	1435	pF
C _{rss}	Reverse Transfer Capacitance			39	60	1
R_g	Gate Resistance		0.1	1.4	3	Ω
SWITCHING	CHARACTERISTICS					
td _(on)	Turn – On Delay Time	V _{DD} = 40 V, I _D = 45 A,		12	22	ns
t _r	Rise Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$		20	36	1
t _{D(off)}	Turn – Off Delay Time			70	112	1
t _f	Fall Time			22	35	1
Qg	Total Gate Charge	V _{GS} = 0V to 10 V V _{GS} = 0V to 4.5 V		59	82	nC
Qg	Total Gate Charge			28	39	1
Q _{gs}	Gate to Source Charge	V _{DD} = 40 V, i _D = 45 A		10		1
Q _{gd}	Gate to Drain "Miller" Charge	7		7		1
Q _{oss}	Output Charge	V _{DD} = 40 V, V _{GS} = 0 V		56		nC
Q _{sync}	Total Gate Charge Sync.	V _{DS} = 0 V, I _D = 45 A		55		1

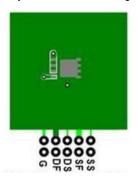
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit		
DRAIN-SOU	DRAIN-SOURCE DIODE CHARACTERISTICS							
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.1 A (Note 2)		0.7	1.2	V		
		V _{GS} = 0 V, I _S = 45 A (Note 2)		0.8	1.3			
t _{rr}	Reverse Recovery Time	I _F = 22 A, di/dt = 300 A/μs		25	39	ns		
Q _{rr}	Reverse Recovery Charge]		86	137	nC		
t _{rr}	Reverse Recovery Time	I _F = 22 A, di/dt = 1000 A/μs		20	32	ns		
Q _{rr}	Reverse Recovery Charge			186	297	nC		

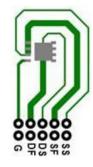
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

 $R_{\theta JA}$ is determined with the device mounted on a 1 in 2 pad 2 oz copper pad on a 1.5 \times 1.5 in. board of FR-4 material. $R_{\theta CA}$ is determined by the user's board design.



a) 50°C/W when mounted on a 1 in² pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. E_{AS} of 486 mJ is based on starting T_J = 25°C; N-ch: L = 3 mH, I_{AS} = 18 A, V_{DD} = 80 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 57 A. 4. Pulsed I_D please refer to Figure 11 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

TYPICAL CHARACTERISTICS T_J = 25°C unless otherwise noted

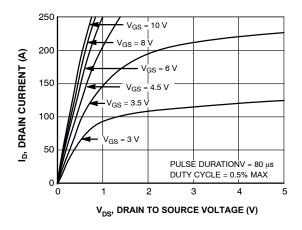


Figure 1. On Region Characteristics

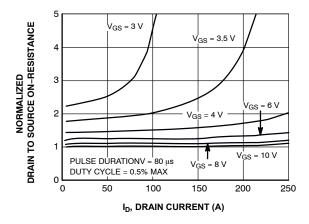


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

TYPICAL CHARACTERISTICS T_J = 25°C unless otherwise noted (continued)

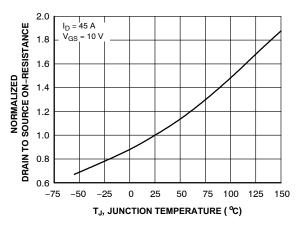


Figure 3. Normalized On Resistance vs. Junction Temperature

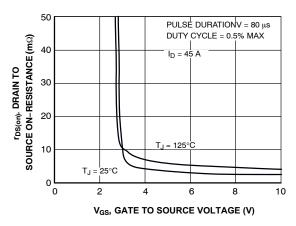


Figure 4. On-Resistance vs. Gate to Source Voltage

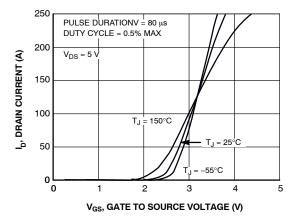


Figure 5. Transfer Characteristics

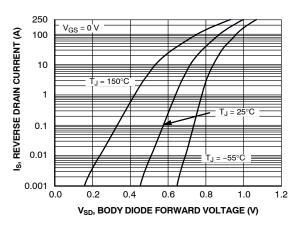


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

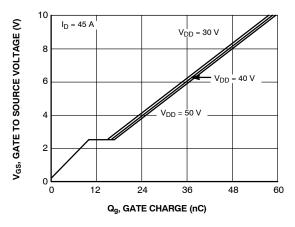


Figure 7. Gate Charge Characteristics

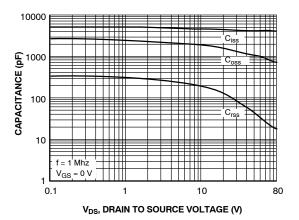


Figure 8. Capacitance vs. Drain to Source Voltage

TYPICAL CHARACTERISTICS T_J = 25°C unless otherwise noted (continued)

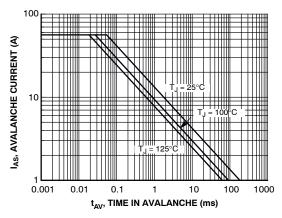


Figure 9. Unclamped Inductive Switching Capability

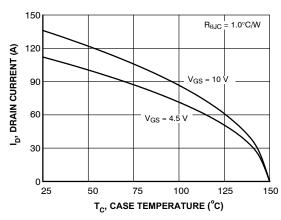


Figure 10. Maximum Continous Drain Current vs. Case Temperature

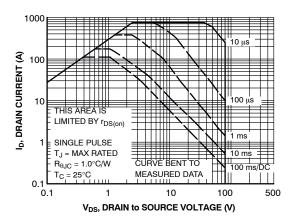


Figure 11. Unclamped Inductive Switching Capability

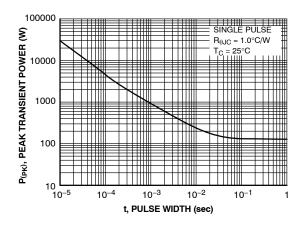


Figure 12. Maximum Continuous Drain Current vs. Case Temperature

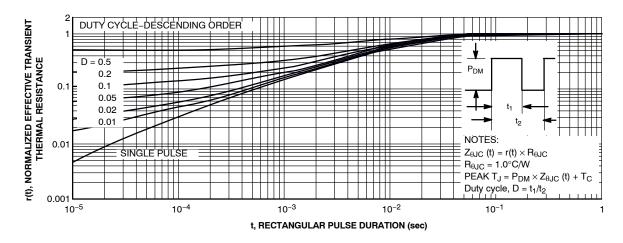
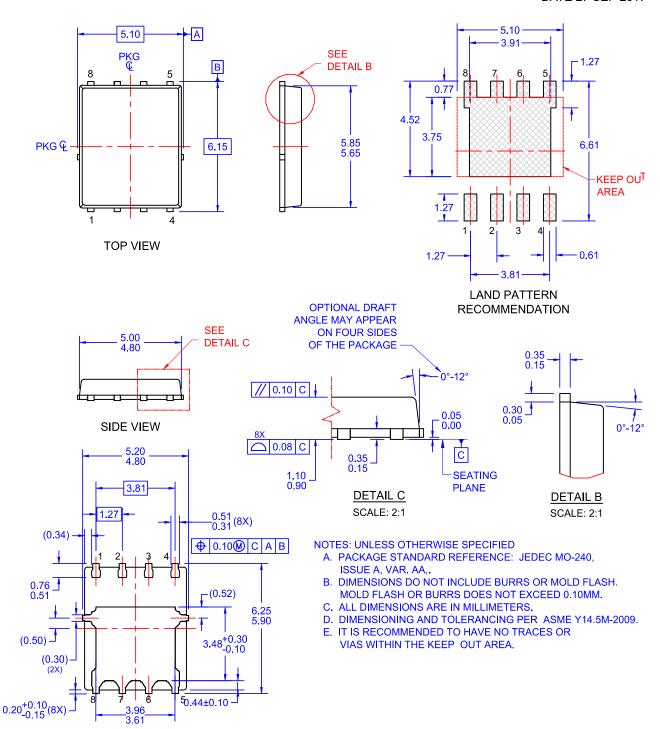


Figure 13. Junction-to-Case Transient Thermal Response Curve

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